

Notice of References Cited

Application/Control No.

09/805,337

Applicant(s)/Patent Under
Reexamination
MURPHY, BRENDAN F.

Examiner

B. Dell Chism

Art Unit

1654

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U.S. PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bork et al. 1996. Trends in Genetics 12:425-427.
	V	Brenner, 1999. Trends in Genetics 15:132-133.
	W	Smith et al. 1997, Nature Biotechnology 15:1222-1223.
	X	Doerks et al. 1998, Trends in Genetics 14:248-250.

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	U	Bork 2000, Genome Research 10:398-400.
	V	Skolnick et al. 2000, Trends in Biotech. 18:34-39.
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